 140 58 th Street, #3C Brooklyn, NY 11220 USA Phone: 718-236-2222 www.leespring.com	MATERIAL DECLARATION FORM – Part I		Dec. 15, 2008
	JIG-101A	EICTA	European Information, Communications and Consumer Electronics Technology Industry Associations
		JGPSSI	Japan Green Procurement Survey Standardization Initiative
		EIA	Electronic Industries Alliance (USA)
		JEDEC	Joint Electron Device Engineering Council (USA)

The undersigned, being a duly authorized representative of **LEE SPRING COMPANY** hereby declares on behalf of the Company:

- That this document has been created in accordance with the recommendations of the **Joint Industry Guide (JIG)** for Material Composition Declaration, developed by **EICTA, JGPSSI, EIA** and **JEDEC** for Electronic Products.
- That the tables below, to the best of our knowledge, contain accurate information on Hazardous Substances in **all catalog products** supplied by Lee Spring to our Customers. The information is based on Suppliers' Certifications, Laboratory Analyses and Material Safety Data Sheets.
- NOTE: The legal and regulatory information in these tables is not a comprehensive listing.


Level A Material and Substance Declaration:

Material/Substance Category Name	Threshold Level	Intentionally added or present (Y/N) above threshold level	Relevant Regulations
Cadmium/Cadmium compounds	1. Intentionally added 2. Any content greater than 100 ppm (0.01%) by weight in homogeneous material.	N	RoHS, JGPSSI
Hexavalent Chromium/ Hexavalent Chromium compounds	1. Intentionally added 2. Any content greater than 1000 ppm (0.1%) by weight in homogeneous material.	N	RoHS, JGPSSI
Lead/Lead compounds	1. Intentionally added 2. Any content greater than 1000 ppm (0.1%) by weight in homogeneous material.	N	RoHS, JGPSSI
Mercury/Mercury compounds	1. Intentionally added 2. Any content greater than 1000 ppm (0.1%) by weight in homogeneous material.	N	RoHS, JGPSSI
Polybrominated Biphenyls (PBBs)	1. Intentionally added 2. Any content greater than 1000 ppm (0.1%) by weight in homogeneous material.	N	RoHS, JGPSSI
Polybrominated Diphenylethers (PBDEs)	1. Intentionally added 2. Any content greater than 1000 ppm (0.1%) by weight in homogeneous material.	N	RoHS, JGPSSI
Perfluorooctane sulfonate (PFOS)	1000 ppm	N	EU Dir. 2006/122/EC
Asbestos	Any content must be reported	N	JGPSSI
Azo colorants	1. Intentionally added 2. Any content greater than 30 ppm in finished textile or leather articles.	N	JGPSSI
Ozone Depleting Substances (CFCs, HCFCs, HBFs, carbon tetrachloride, etc.)	Any content must be reported	N	JGPSSI
Polychlorinated Biphenyls and Terphenyls	Intentionally added	N	JGPSSI

(PCBs, PCTs)			
Polychlorinated Naphthalenes (more than 3 chlorine atoms)	Intentionally added	N	JGPSSI
Radioactive Substances	Intentionally added	N	JGPSSI
Certain Shortchain Chlorinated Paraffins (C10-C13)	1. Intentionally added 2. Any content greater than 1000 ppm (0.1%) by weight.	N	JGPSSI
Certain Tributyl Tin (TBT) and Triphenyl Tin (TPT) compounds	Intentionally added	N	JGPSSI
Tributyl Tin Oxide (TBTO)	Intentionally added	N	JGPSSI

Level B Material and Substance Declaration


Material/Substance Category Name	Threshold Level	Intentionally added or present (Y/N) above threshold level	Relevant Regulations
Antimony/Antimony compounds	1000 ppm	N	Not applicable
Arsenic/Arsenic compounds	1000 ppm	N	Not applicable
Beryllium/Beryllium compounds	1000 ppm	N	Not applicable
Bismuth/Bismuth compounds	1000 ppm	N	Not applicable
Brominated Flame Retardants (other than PBBs or PBDEs)	1000 ppm	N	Not applicable
Certain Phthalates	1000 ppm	N	Not applicable
Nickel (external applications only, where nickel is likely to result in prolonged skin exposure)	Release of Nickel not to exceed 0.5 mg/cm ² /week when tested to DIN EN 1811	N	76/769/EEC Marketing and use of Dangerous Substances and Amendment 94/27/EC
Polyvinyl chloride (PVC)	1000 ppm	N	Not applicable
Selenium/Selenium compounds	1000 ppm	N	Not applicable

	MATERIAL DECLARATION FORM – Part II		
REACH Candidate List of SVHC Released by ECHA on October 28, 2008		ECHA	European Chemical Agency

NOTE: None of the below listed substances is present in our catalog products (articles).

No.	SUBSTANCE NAME	Threshold Level of substances in articles (springs)	Substance presence above threshold level Y/N	Relevant Regulations
1	Anthracene	Above 0.1% (w/w)	N	ECHA/PR/08/38-REV
2	4,4' Diaminodiphenylmethane	Above 0.1% (w/w)	N	ECHA/PR/08/38-REV
3	Dibutyl phthalate	Above 0.1% (w/w)	N	ECHA/PR/08/38-REV
4	Cobalt dichloride	Above 0.1% (w/w)	N	ECHA/PR/08/38-REV
5	Diarsenic pentaoxide	Above 0.1% (w/w)	N	ECHA/PR/08/38-REV
6	Diarsenic trioxide	Above 0.1% (w/w)	N	ECHA/PR/08/38-REV
7	Sodium dichromate	Above 0.1% (w/w)	N	ECHA/PR/08/38-REV
8	5-tert-butyl-2,4,6-trinitro-m-xylene (musk xylene)	Above 0.1% (w/w)	N	ECHA/PR/08/38-REV
9	Bis (2-ethy(hexyl)phthalate) (DEHP)	Above 0.1% (w/w)	N	ECHA/PR/08/38-REV
10	Hexabromocyclododecane (HBCDD) and all major diastereoisomers identified (α-HBCDD,β-HBCDD,γ-HBCDD)	Above 0.1% (w/w)	N	ECHA/PR/08/38-REV
11	Alkanes, C10-13, chloro (Short Chain Chlorinated Paraffins)	Above 0.1% (w/w)	N	ECHA/PR/08/38-REV
12	Bis (tributyltin)oxide	Above 0.1% (w/w)	N	ECHA/PR/08/38-REV
13	Lead hydrogen arsenate	Above 0.1% (w/w)	N	ECHA/PR/08/38-REV
14	Benzyl butyl phthalate	Above 0.1% (w/w)	N	ECHA/PR/08/38-REV
15	Triethyl arsenate	Above 0.1% (w/w)	N	ECHA/PR/08/38-REV

Name: **Val Fridmanovich**

Authorized Signature: 

Title: **Safety and Reliability Manager**

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